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Sommario/riassunto	Broad-based and hands-on, Phase-Lock Basics, Second Edition is both easy to understand and easy to customize. The text can be used as a theoretical introduction for graduate students or, when used with

MATLAB simulation software, the book becomes a virtual laboratory for working professionals who want to improve their understanding of the design process and apply it to the demands of specific situations. This second edition features a large body of new statistical data obtained from simulations and uses available experimental data for confirmation of the simulation results.